

Notice of References Cited

Application/Control No.
09/784,015

Ap .nt(s)/Patent Under Reexam
Eyende et al

Examiner
Nitin Parekh

Art Unit
2811

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U.S. PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
X	A	5,528,222	6/1996	Moskowitz et al	340	572
	B					
	C					
	D					
	E					
	F					
	G					
	H					
	I					
	J					
	K					
	L					
	M					

FOREIGN PATENT DOCUMENTS

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	P						
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	R						
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Notice of References Cited	Applicant/Patent Eyende et al		Application/Control No. 09/784,015	
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U.S. PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
X	A	6,282,095	8/2001	Houghton et al	361	704
X	B	4,733,245	3/1988	Mussler	343	705
	C					
	D					
	E					
	F					
	G					
	H					
	I					
	J					
	K					
	L					
	M					

FOREIGN PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Country	Name	Classification ²	
	N	09,237,867	9/1997	JAPAN	TAKESHI	25	00
	O	08,250,913	9/1996	Japan	Masahito	5	08
	P						
	Q						
	R						
	S						
	T						

NON-PATENT DOCUMENTS

		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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